

IRF634B/IRFS634B

250V N-Channel MOSFET

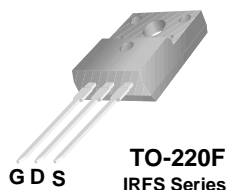
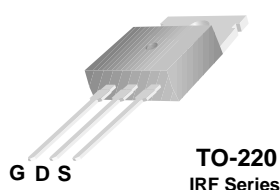
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters and switch mode power supplies.

Features

- 8.1A, 250V, $R_{DS(on)} = 0.45\Omega @ V_{GS} = 10V$
- Low gate charge (typical 29 nC)
- Low C_{rss} (typical 20 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | IRF634B | IRFS634B | Units |
|----------------|---|-------------|----------|---------------------|
| V_{DSS} | Drain-Source Voltage | 250 | | V |
| I_D | Drain Current - Continuous ($T_C = 25^\circ\text{C}$) - Continuous ($T_C = 100^\circ\text{C}$) | 8.1 | 8.1 * | A |
| | | 5.1 | 5.1 * | A |
| I_{DM} | Drain Current - Pulsed (Note 1) | 32.4 | 32.4 * | A |
| V_{GSS} | Gate-Source Voltage | ± 30 | | V |
| E_{AS} | Single Pulsed Avalanche Energy (Note 2) | 200 | | mJ |
| I_{AR} | Avalanche Current (Note 1) | 8.1 | | A |
| E_{AR} | Repetitive Avalanche Energy (Note 1) | 7.4 | | mJ |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | 5.5 | | V/ns |
| P_D | Power Dissipation ($T_C = 25^\circ\text{C}$) - Derate above 25°C | 74 | 38 | W |
| | | 0.59 | 0.3 | W/ $^\circ\text{C}$ |
| T_J, T_{STG} | Operating and Storage Temperature Range | -55 to +150 | | $^\circ\text{C}$ |
| T_L | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300 | | $^\circ\text{C}$ |

* Drain current limited by maximum junction temperature.

Thermal Characteristics

| Symbol | Parameter | IRF634B | IRFS634B | Units |
|-----------------|--|---------|----------|---------------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case Max. | 1.69 | 3.29 | $^\circ\text{C}/\text{W}$ |
| $R_{\theta CS}$ | Thermal Resistance, Case-to-Sink Typ. | 0.5 | -- | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient Max. | 62.5 | 62.5 | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------------------------------|---|---|-----|------|------|---------------------------|
| Off Characteristics | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$ | 250 | -- | -- | V |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$, Referenced to 25°C | -- | 0.27 | -- | $\text{V}/^\circ\text{C}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 250\text{ V}, V_{GS} = 0\text{ V}$ | -- | -- | 10 | μA |
| | | $V_{DS} = 200\text{ V}, T_C = 125^\circ\text{C}$ | -- | -- | 100 | μA |
| I_{GSSF} | Gate-Body Leakage Current, Forward | $V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$ | -- | -- | 100 | nA |
| I_{GSSR} | Gate-Body Leakage Current, Reverse | $V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$ | -- | -- | -100 | nA |

On Characteristics

| | | | | | | |
|--------------|-----------------------------------|--|-----|-------|------|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$ | 2.0 | -- | 4.0 | V |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS} = 10\text{ V}, I_D = 4.05\text{ A}$ | -- | 0.345 | 0.45 | Ω |
| g_{FS} | Forward Transconductance | $V_{DS} = 40\text{ V}, I_D = 4.05\text{ A}$ (Note 4) | -- | 7.6 | -- | S |

Dynamic Characteristics

| | | | | | | |
|------------|------------------------------|--|----|-----|------|----|
| C_{iss} | Input Capacitance | $V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$ | -- | 780 | 1000 | pF |
| C_{oss} | Output Capacitance | | -- | 95 | 125 | pF |
| C_{riss} | Reverse Transfer Capacitance | | -- | 20 | 25 | pF |

Switching Characteristics

| | | | | | | |
|--------------|---------------------|--|-------------|-----|-----|-----|
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD} = 125\text{ V}, I_D = 8.1\text{ A},$ $R_G = 25\ \Omega$ | -- | 15 | 40 | ns |
| t_r | Turn-On Rise Time | | -- | 75 | 160 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | -- | 100 | 210 | ns |
| t_f | Turn-Off Fall Time | | (Note 4, 5) | -- | 65 | 140 |
| Q_g | Total Gate Charge | $V_{DS} = 200\text{ V}, I_D = 8.1\text{ A},$ $V_{GS} = 10\text{ V}$ | -- | 29 | 38 | nC |
| Q_{gs} | Gate-Source Charge | | -- | 4.2 | -- | nC |
| Q_{gd} | Gate-Drain Charge | | (Note 4, 5) | -- | 14 | -- |

Drain-Source Diode Characteristics and Maximum Ratings

| | | | | | | |
|----------|---|---|----|------|-----|---------------|
| I_S | Maximum Continuous Drain-Source Diode Forward Current | -- | -- | 8.1 | A | |
| I_{SM} | Maximum Pulsed Drain-Source Diode Forward Current | -- | -- | 32.4 | A | |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0\text{ V}, I_S = 8.1\text{ A}$ | -- | -- | 1.5 | V |
| t_{rr} | Reverse Recovery Time | $V_{GS} = 0\text{ V}, I_S = 8.1\text{ A},$ | -- | 170 | -- | ns |
| Q_{rr} | Reverse Recovery Charge | $di_F / dt = 100\text{ A}/\mu\text{s}$ (Note 4) | -- | 0.91 | -- | μC |

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $L = 4.9\text{ mH}, I_{AS} = 8.1\text{ A}, V_{DD} = 50\text{ V}, R_G = 25\ \Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{SD} \leq 8.1\text{ A}, di/dt \leq 300\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300\ \mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

Typical Characteristics

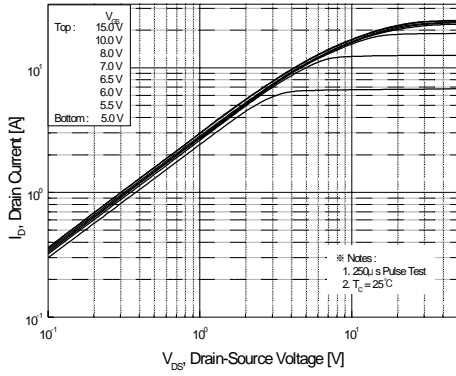


Figure 1. On-Region Characteristics

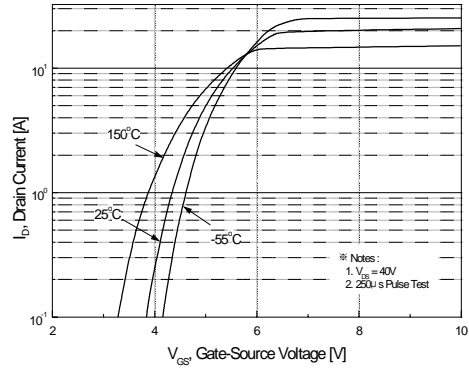


Figure 2. Transfer Characteristics

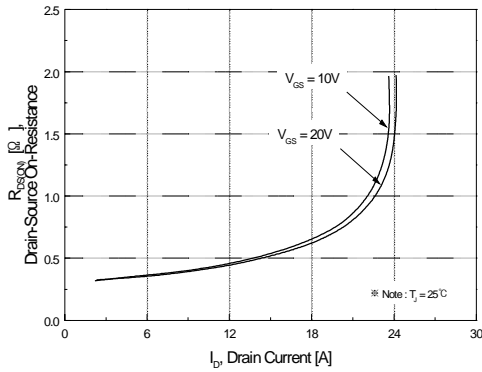


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

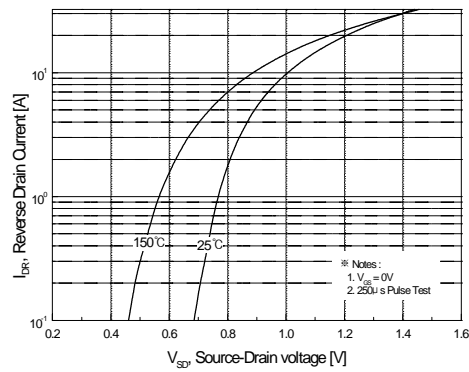


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

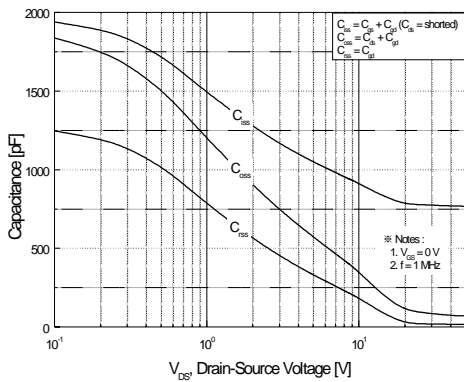


Figure 5. Capacitance Characteristics

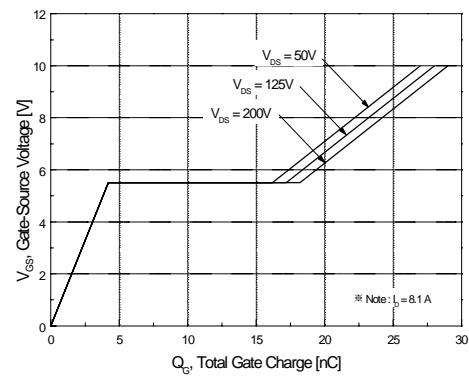


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

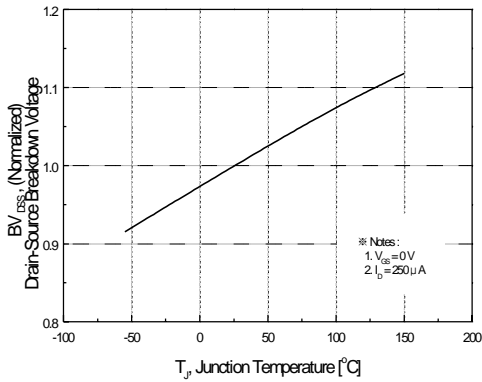


Figure 7. Breakdown Voltage Variation vs Temperature

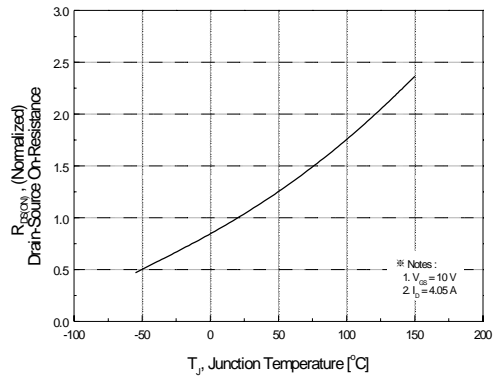


Figure 8. On-Resistance Variation vs Temperature

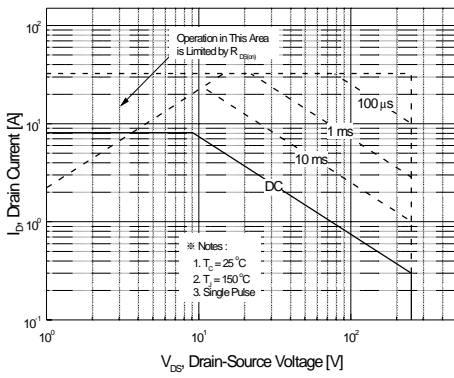


Figure 9-1. Maximum Safe Operating Area for IRF634B

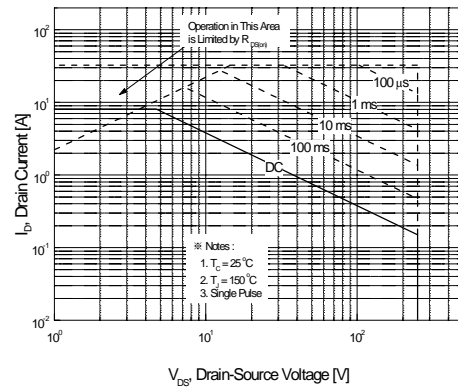


Figure 9-2. Maximum Safe Operating Area for IRFS634B

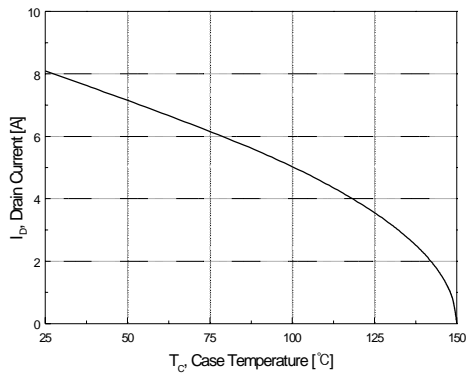


Figure 10. Maximum Drain Current vs Case Temperature

Typical Characteristics (Continued)

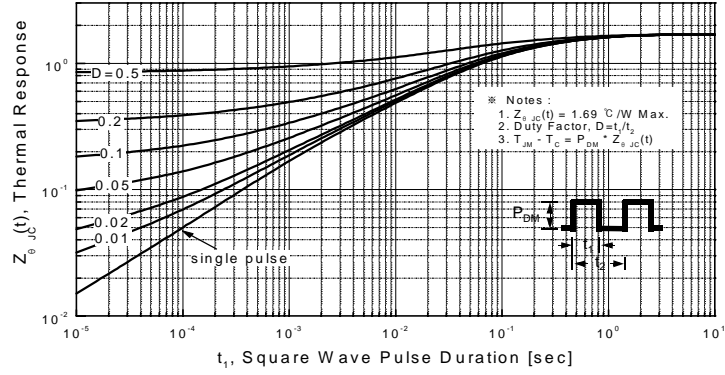


Figure 11-1. Transient Thermal Response Curve for IRF634B

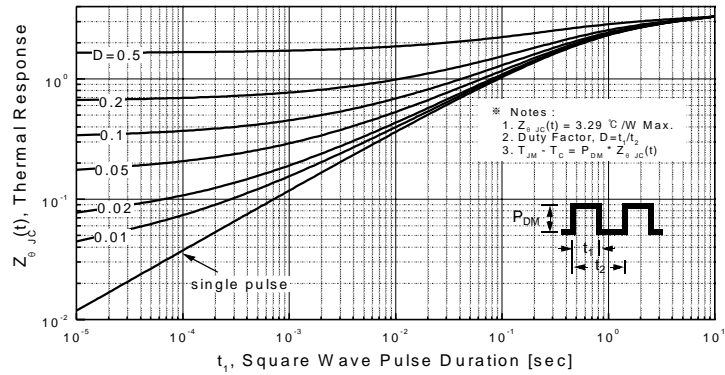
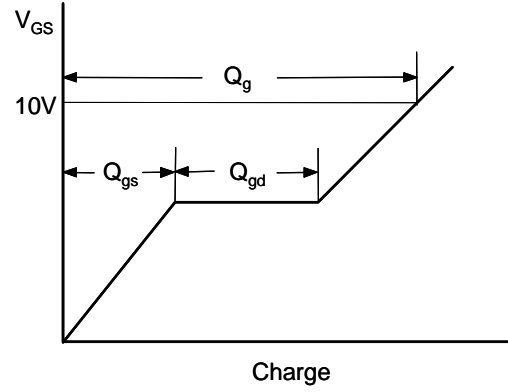


Figure 11-2. Transient Thermal Response Curve for IRFS634B

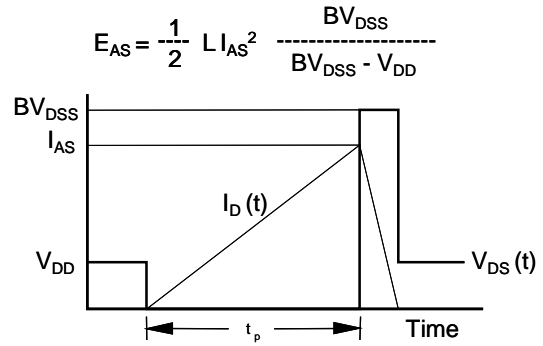
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

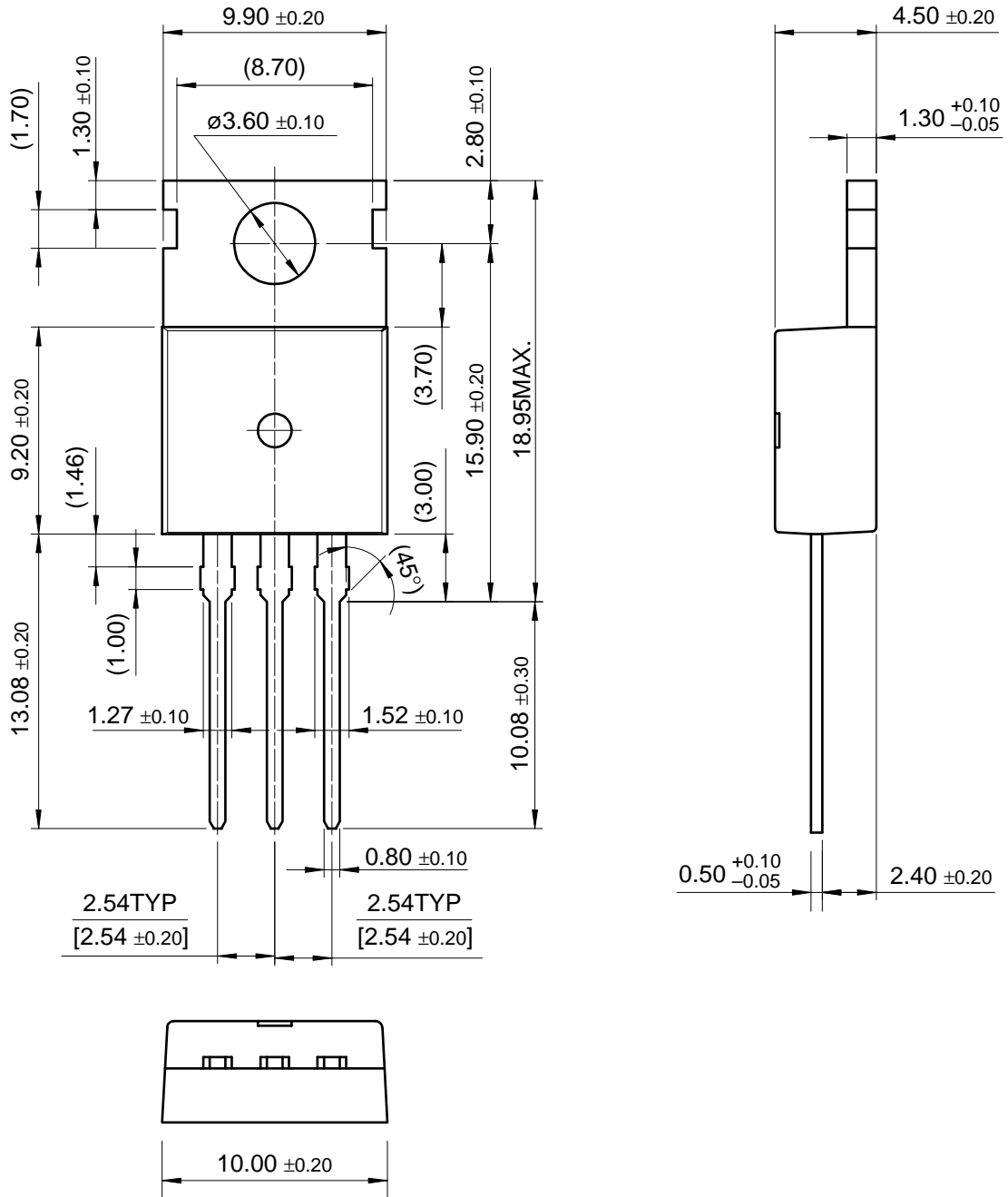


Peak Diode Recovery dv/dt Test Circuit & Waveforms



Package Dimensions

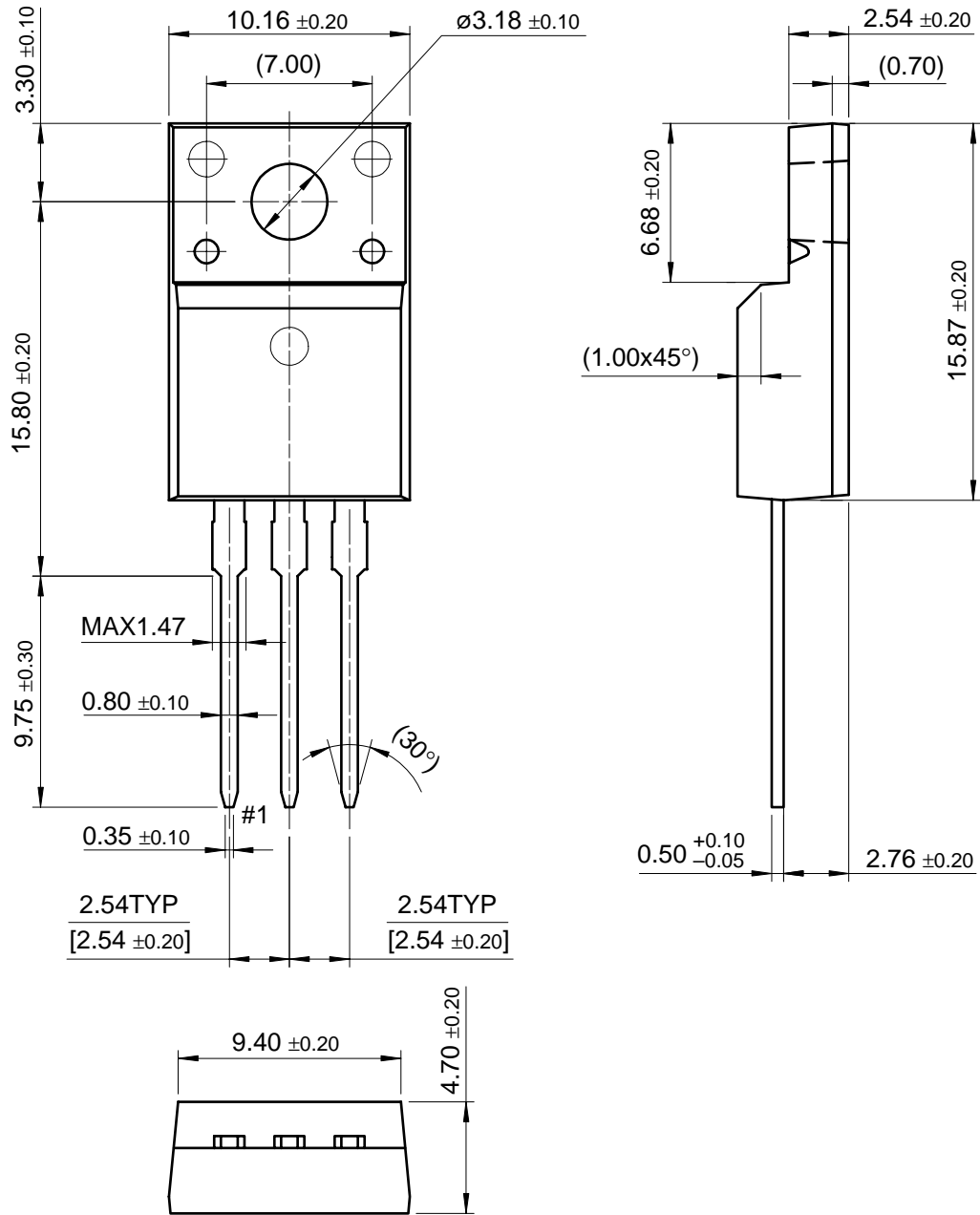
TO-220



Dimensions in Millimeters

Package Dimensions (Continued)

TO-220F



IRF634B/IRFS634B

Dimensions in Millimeters

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